## Application/Control No. Applicant(s)/Patent Under Reexamination 10/671,473 YAGISHITA ET AL. Notice of References Cited Examiner Art Unit Page 1 of 1 Ly D Pham 2818

## **U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	Α	US-2004/0184329 A1	09-2004	Horiguchi et al.	365/200
*	В	US-2004/0160836 A1	08-2004	Takase, Satoru	365/200
*	С	US-2004/0062095 A1	04-2004	Templeton et al.	365/200
*	D	US-2004/0085826 A1	05-2004	Sakata et al.	365/200
*	E	US-2003/0107928 A1	06-2003	Sakata, Takeshi	365/200
*	F	US-2002/0003725 A1	01-2002	WADA, OSAMU	365/200
*	G	US-6,735,727 B1	05-2004	Lee, June	714/711
	H	US-			
	1	US-			
	J	US-			
	К	US-			
	L	US-			
	М	US-			

## FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	0					
	Р				,	
	Q					
	R	^				
	S					,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,
	Т	·				

## NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)					
	O						
	>						
	8						
	X						

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)

Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.